

Notice of References Cited		Application/Control No. 10/797,579	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner Yewebdar T. Tadesse	Art Unit 1734	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,024,835	05-1977	Scheu et al.	118/52
	B	US-6,837,967	01-2005	Berman et al.	156/345.3
	C	US-6,436,472	08-2002	Sago et al.	427/240
	D	US-5,342,738	08-1994	Ikeda, Rikio	430/325
	E	US-6,307,390	10-2001	Akaike et al.	324/758
	F	US-2004/0126923 a	07-2004	Benson, Peter A.	438/058
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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